| Question | | n | Expected Answers | Μ | Additional Guidance |
|----------|---|----------|---|------------|---|
| 1 | | | | | |
| | а | i | method of producing coherent sources at S ₁ and S ₂ | B1 | e.g. initial single slit |
| | | | light (waves) from the two slits/sources must be coherent; | B1 | |
| | | | that is, they must have a constant phase relationship/difference | B1 | |
| | | | slits must be narrow/close together (so that diffraction patterns | | |
| | | | overlap) | B1 | |
| | | | light (waves) from two slits must have similar amplitudes/intensities | B1 | max 3 marks from 5 marking points |
| | | ii | bright: constructive interference occurs/waves add to give a | | |
| | | | maximum amplitude at the screen | B1 | |
| | | | path difference between slits and screen is a whole/integer number | | accept explanation in terms of distance or phase |
| | | | of wavelengths/waves arrive in phase at screen | B1 | |
| | | | dark: destructive interference occurs/waves add to give a minimum | | |
| | | | amplitude/zero at the screen | B1 | |
| | | | path difference between slits and screen is an odd half number of | 5. | accept explanation in terms of distance or phase |
| | | | wavelengths/waves arrive out of/in antiphase at screen | B1 | |
| | b | <u> </u> | $7.4/5 = 1.48 \times 10^{-5} \text{ (m)}$ | B1 | accept 1.5 mm |
| | | II | $\lambda = xd/L$ | C1 | using 1.5 mm gives 600 nm |
| | | | $= 1.48 \times 10^{\circ} \times 0.6 \times 10^{\circ}/1.5$ | C1 | ect(b)(i) e.g. 4 92 x 10' for 1.23 mm |
| | | | $= 5.9(2) \times 10^{-7} (m)$ | A1 | accept 590 nm |
| | С | | pattern/fringes vanish | B1 | |
| | | | because there is now no interference from light from the two slits/AW | B1 | |
| | | | light spreads out over whole/similar region | B1 | |
| | | | light intensity (at screen) is less | B1 | |
| | | | diffraction spreads light | B1 | |
| | | | simple description of single slit pattern | B1 | e.g. bright in middle and dim at edges/sketch of bell |
| | | | further features of single all pattern | D O | snape |
| | | | Turther reatures of single slit pattern | BZ | max 3 marks from 8 marking points |
| | | | l otal question 6 | 14 | |

| Question | | Expected Answers | Μ | Additional Guidance |
|----------|---|---|----------------------------------|--|
| 2 | | | | |
| | а | reference to a transverse wave or to vibrations in plane normal to the direction of (energy) propagation | B1 | can be answered with suitable diagram(s) |
| | | (containing the direction of propagation) | B1 | NOT the wave oscillating in one plane |
| | b | set up apparatus, e.g. tray of water on table with lamp/light from window rotate the filter rotation of filter changes the image intensity/brightness/AW correct orientation for maximum and minimum intensities of image move head up or down to change angle of reflected light observed use of protractor to measure angles image/reflection becomes partially plane polarised/ image changes | B1 B1 B1 B1 B1 B1 | QWC mark essential for full marks allow from bright to zero or vice versa transmission axis parallel to water surface for maximum and perpendicular for minimum can hold head still and move lamp |
| | | from bright to dim but does not disappear | B1 | max 3 from 6 marking points + QWC mark |
| | C | I = I ₀ cos ² θ where I ₀ is the maximum intensity (of the polarised beam) when θ is zero maximum intensity transmitted/ image bright when θ is 90° minimum/zero intensity transmitted/image dim/vanished | B1 B1 B1 B1 | allow incident/original/initial for maximum |
| | | Total question 7 | 10 | |

| Question | | on | Expected Answers | Μ | Additional Guidance |
|----------|---|-----|--|----|---|
| 3 | | | | | |
| | а | i | travel through a vacuum | B1 | allow travel at c (in a vacuum) |
| | b | ii | A gamma; C uv; | B3 | allow 1 mark for A radio; C ir; |
| | | | F microwave | | F X-ray |
| | С | i | $3.0 \times 10^8 = 1.0 \times 10^9 \lambda$ | C1 | |
| | | | $\lambda = 0.30 \text{ m}$ | A1 | allow 0.3 no SF error |
| | | ii | aerial length = $\lambda/2$ = 0.15 m | A1 | ecf (c)(i) |
| | | iii | emitted wave is (plane) polarised | B1 | allow max signal initially/at 0° |
| | | | detecting aerial will receive weaker signal/cos θ component | | |
| | | | when it is rotated (through angle θ)/AW | B1 | |
| | | | signal falls to zero at 90° | B1 | |
| | | | and then rises to max again at 180° | | max 3 marks from 4 marking points |
| | d | i | UV-A causes tanning or skin ageing ; most of (99%) uv light; | B1 | accept values within ranges with tolerance of |
| | | | 400-31 | | 20 nm allow $\lambda_A > \lambda_B > \lambda_C$ for 1 mark |
| | | | UV-B causes damage or sunburn or skin cancer; 315-260 nm | B1 | |
| | | | UV-C is filtered out by atmosphere/ozone layer; 260-100 nm | B1 | max 3 marks from 7 marking points |
| | | ii | filters out/blocks/reflects/absorbs UV(-B) | B1 | allow chemicals prevent sunburn/skin cancer |
| | | | | | not stops UV penetrating skin |
| | е | | energy of the infra-red photon is less than | B1 | accept frequency and threshold frequency or |
| | | | the work function of the metal surface | B1 | wavelength and threshold wavelength used |
| | | | | | correctly in place of energy and work function |
| | | | | | 1 mark only: energy of the uv photon greater |
| | | | | | than work function with no mention of ir |
| | | | Total question 5 | 16 | |